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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/644,835	CHEN, YU-YU	
Examiner	Art Unit	

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Brian T. Gedeon

SEARCHED			
Class	Subclass	Date	Examiner
600	509, 508	2/22/2006	BTG
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
Search from Carl Layno.	2/22/2206	BTG
Please see attached search history.	2/22/2006	BTG